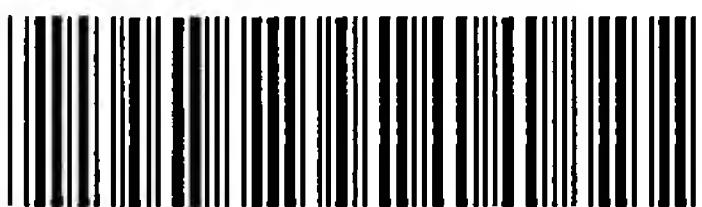


## **Search Notes**



**Application/Control No.**

10/710,667

**Examiner**

Jason Uhlenhake

**Applicant(s)/Patent under  
Reexamination**

CHANG, WEN-CHI

## Art Unit

2853

SEARCHED

# SEARCH NOTES (INCLUDING SEARCH STRATEGY)

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner